Search Notes



Application/Control No.

Applicant(s)/Patent Under

BIJ DE VAATE ET AL.

Reexamination

10565722

Art Unit

Examiner

Duong, Dieu Hien T

2821

SEARCHED

Class	Subclass	Date	Examiner
343	767,770,853	9/6/2007	dd

SEARCH NOTES

Search Notes	Date	Examiner
See east search history	9/6/2007	dd
Consulted with Trinh Dinh, primary 315	9/5/2007	dd

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

U.S. Patent and Trademark Office Part of Paper No.: 20070830